Search Notes		

App	licati	ion/C	ontro	l No.

Applicant(s)/Patent under Reexamination
GLUCK ET AL.

09/985,788

Art Unit

Examiner

2155

Liang-che Alex Wang

SEARCHED			
Class	Subclass	Date	Examiner
709	217, 230, 231, 236, 245, 248	10/4/2005	LW
710	70	10/4/2005	LW
725	115	10/4/2005	LW
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST TEXT Search: USPAT, USPUB, EPO, JPO, DERWENT	10/4/2005	LW
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